Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/785,598	LEE ET AL.
Examiner	Art Unit
Jacob Y. Choi	2875

	SEAR	CHED	
Class	Subclass	Date	Examiner
362	328, 330, 26, 311, 606, 609	9/27/2005	JC
362	610	9/27/2005	JC
359	64, 65	9/27/2005	JC
ALL	ALL	2/9/2006	JC
		-	

INTERFERENCE SEARCHED		
Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Class/Subclass Search	9/27/2005	JC
Text Search Conducted by Examiner	9/27/2005	JC
Updated Class/Subclass & Text Search Conducted by Examiner	2/9/2006	JC